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SERIAL NUMBER 09/608,311	FILING DATE 06/30/2000 RULE	CLASS 324	GROUP ART UNIT 2829	ATTORNEY DOCKET NO. IB-1506 LBNL
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APPLICANTS

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** CONTINUING DATA *****

This appln claims benefit of 60/141,698 06/30/1999
 and is a CIP of 09/158,037 09/22/1998 PAT 6,173,604 *He*
 which is a CIP of 08/717,321 09/20/1996 PAT 5,821,410
 and claims benefit of 60/059,471 09/22/1997

** FOREIGN APPLICATIONS ***** *No*

IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** SMALL ENTITY **
 ** 08/31/2000

Foreign Priority claimed 35 USC 119 (a-d) conditions met	<input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> Met after Allowance	STATE OR COUNTRY CA	SHEETS DRAWING 23	TOTAL CLAIMS 6	INDEPENDENT CLAIMS 3
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Verified and Acknowledged

Examiner's Signature *He* Initials

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TITLE
 Analytical scanning evanescent microwave microscope and control stage

☐ All Fees